

ATH400M1G

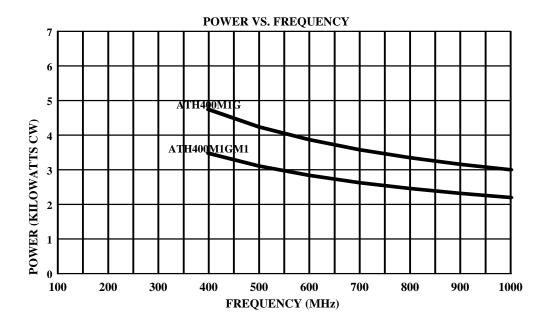
- M1
- Antenna
- 400MHz-1000MHz

Features

The Model ATH400M1G is a high gain horn antenna specially designed for use in RF Susceptibility Testing. Its high gain characteristics permit achievement of higher electric fields per watt of input power. Exhibiting generally increasing gain with increasing frequency, the ATH400M1G helps compensate for losses that occur elsewhere in an RF test system at high frequencies. The Model ATH400M1G is intended for use with the 2000W1000 and other high power amplifiers.

The ATH400M1G can also be custom calibrated to the user's requirement for use in RF emission testing. The calibrated model is designated by adding a 'CC' suffix to the model. Calibration details must be provided using Form 701. Contact factory for details.

The export classification for this equipment is EAR99. These commodities, technology or software are controlled for export in accordance with the U.S. Export Administration Regulations. Diversion contrary to U.S. law is prohibited.



AR RF/Microwave Instrumentation 160 School House Rd Souderton, PA 18964 215-723-8181

For an applications engineer call:800.933.8181

www.arworld.us



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- M1
- Antenna
- 400MHz—1000MHz

Specifications and Graphs

FREQUENCY RANGE: 400-1000MHz

POWER INPUT: See graph

POWER GAIN (over isotropic): 10 dBi minimum, typically increasing to 15 dBi at 1000MHz

IMPEDANCE: 50 ohms nominal

VSWR: Maximum 2.5:1; Average 1.5:1 BEAMWIDTH (average): See curve

CONNECTOR: Quick change block. See Model

Configurations.

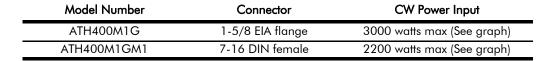
MOUNTING PROVISIONS: Rear flange for wall mount. Pads with 1/4-20 thread for tripod mount.

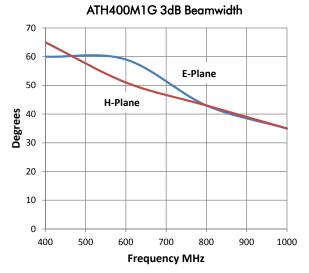
WEIGHT: 9.1 kg (20 lbs)

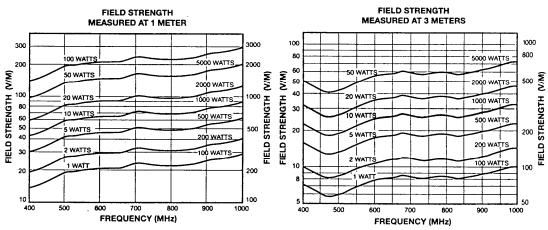
SIZE (W x H x D): 56.4 x 79.3 x 73.7 cm (22.2 x

31.2 x 29 in

EXPORT CLASSIFICATION: EAR99







Field strengths have been measured in free-space conditions. Individual shielded rooms, amplifiers, and test-system conditions will influence performance. Field strength also varies with frequency and position of antenna and EUT in non-anechoic testing environment.